Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/656,326	HIMI ET AL.		
Examiner	Art Unit		
Cuong Q. Nguyen	2811		

SEARCHED								
Class	Subclass	Date	Examiner					
438	404-405 413 424-430	6-22-06	W					
257	506-570							
	347							
	719	-						

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Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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